PNP General-Purpose Amplifier

PZTA56, MMBTA56

ON Semiconductor®

www.onsemi.com

General Description

This device is designed for general−purpose amplifier applications at collector currents to 300 mA. Sourced from process 73.

Features

- These are Pb−Free Devices

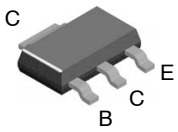
ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted) (Note 1, Note 2)

Symbol	Parameter	Value	Unit
V_{CES}	Collector−Emitter Voltage	−80	V
V_{CBO}	Collector−Base Voltage	−80	V
V_{EBO}	Emitter−Base Voltage	−4.0	V
I_C	Collector Current − Continuous	−500	mA
T_J, T_{STG}	Operating and Storage Junction Temperature Range	−55 to + 150	°C

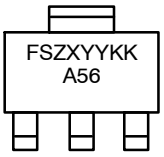
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. These ratings are based on a maximum junction temperature of 150°C.
2. These are steady−state limits. ON Semiconductor should be consulted on applications involving pulsed or low−duty−cycle operations.

MARKING DIAGRAM

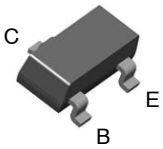


SOT−223−4
CASE 318H

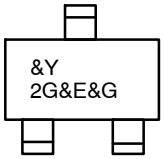


FS	= On Semiconductor Logo
Z	= Assembly Plant Code
X	= Single Digit Numeric Year Code Last Digit of the Calendar Year
YY	= Two Digit Weekly Numeric Code
KK	= Two Alphanumeric Character Lot Code
A56	= Device Code

MARKING DIAGRAM



SOT−23−3
CASE 318BM



&Y	= ON Semiconductor Logo
2G	= Specific Device Code
&E	= Designated Space
&G	= Pb−Free Package

ORDERING INFORMATION

Device	Package	Shipping†
PZTA56	SOT−223−4	4000 Tape & Reel
MMBTA56	SO−23−3	3000 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Max		Unit
		PZTA56 (Note 3)	**MMBTA56** (Note 4)	
P_D	Total Device Dissipation	1000	350	mW
	Derate Above 25°C	8.0	2.8	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction−to−Ambient	125	357	°C/W

3. PCB size: FR−4, 76 mm x 114 mm x 1.57 mm (3.0 inch x 4.5 inch x 0.062 inch) with minimum land pattern size.
4. Device mounted on FR−4 PCB 36 mm x 18 mm x 1.5 mm; mounting pad for the collector lead minimum 6cm^2.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Max	Unit
$V_{(BR)CEO}$	Collector−Emitter Breakdown Voltage (Note 5)	I_C = −1.0 mA, I_B = 0	−80		V
$V_{(BR)CBO}$	Collector−Base Breakdown Voltage	I_C = −100 μA, I_E = 0	−60		V
$V_{(BR)EBO}$	Emitter−Base Breakdown Voltage	I_E = −100 μA, I_C = 0	−4.0		V
I_{CES}	Collector Cut−Off Current	V_{CE} = −60 V, I_B = 0		−0.1	μA
I_{CBO}	Collector Cut−Off Current	V_{CB} = −80 V, I_E = 0		−0.1	μA
h_{FE}	DC Current Gain	I_C = −10 mA, V_{CE} = −1.0 V	100		
		I_C = −100 mA, V_{CE} = −1.0 V	100		
V_{CE}(sat)	Collector−Emitter Saturation Voltage	I_C = −100 mA, I_B = −10 mA		−0.25	V
V_{BE}(on)	Base−Emitter On Voltage	I_C = −100 mA, V_{CE} = −1.0 V		−1.2	V
f_T	Current Gain − Bandwidth Product	I_C = −100 mA, V_{CE} = −1.0 V, f = 100 MHz	50		MHz

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse test: pulse width ≤ 300 μs, duty cycle ≤ 2.0%.

TYPICAL PERFORMANCE CHARACTERISTICS

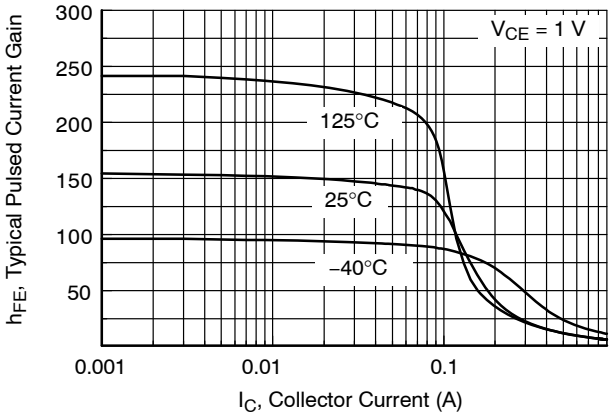

Figure 1. Typical Pulsed Current Gain vs. Collector Current

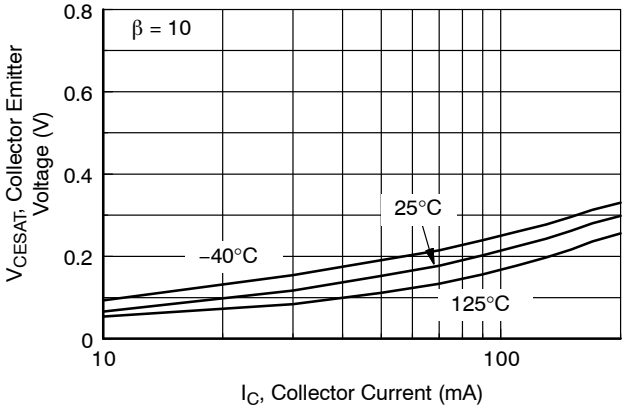

Figure 2. Collector− Emitter Saturation Voltage vs. Collector Current

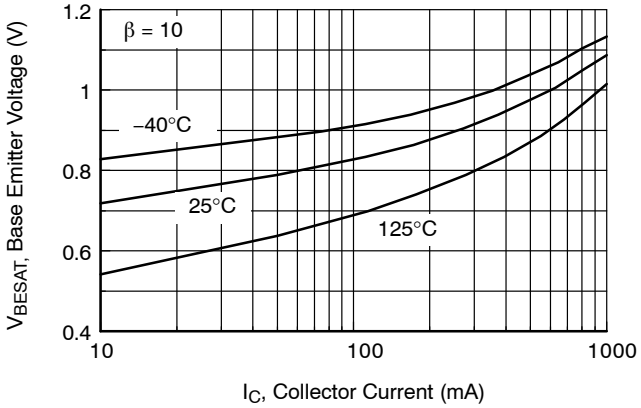

Figure 3. Base−Emitter Saturation Voltage vs. Collector Current

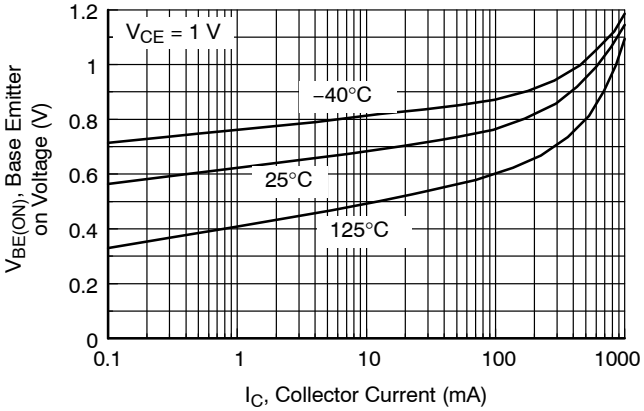

Figure 4. Base−Emitter On Voltage vs. Collector Current

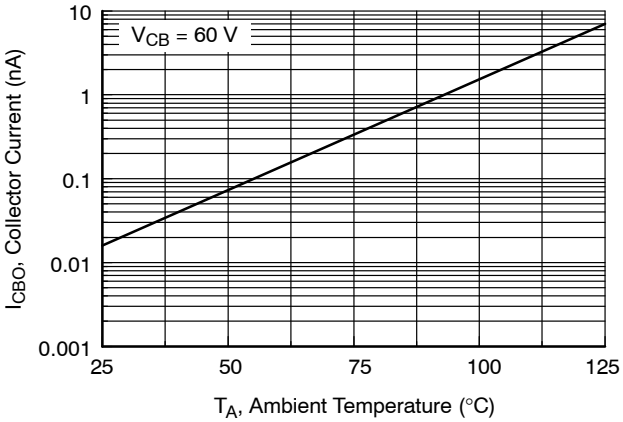

Figure 5. Collector Cut−Off Current vs. Ambient Temperature

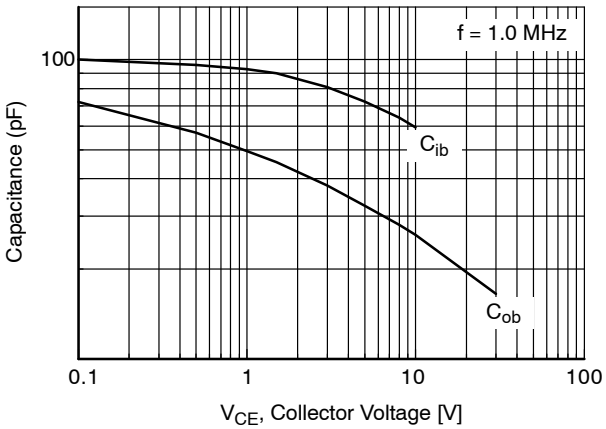

Figure 6. Input and Output Capacitance vs. Reverse Voltage

TYPICAL CHARACTERISTICS (continued)

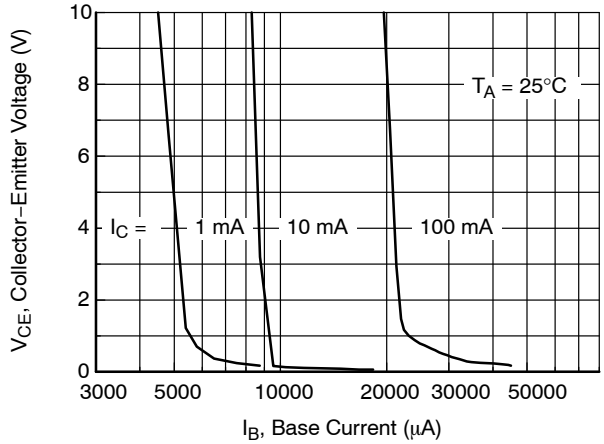

Figure 7. Collector Saturation Region

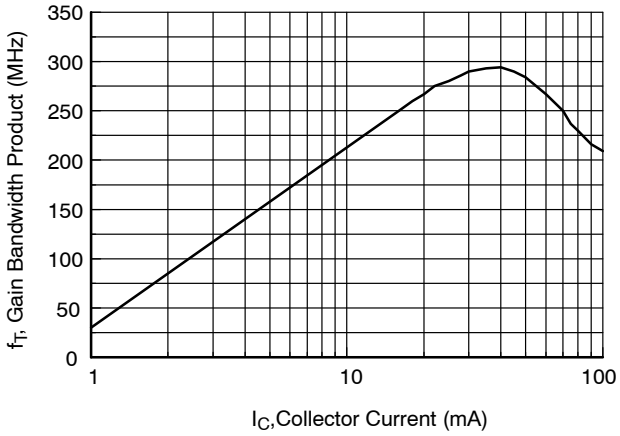

Figure 8. Gain Bandwidth Product vs. Collector Current

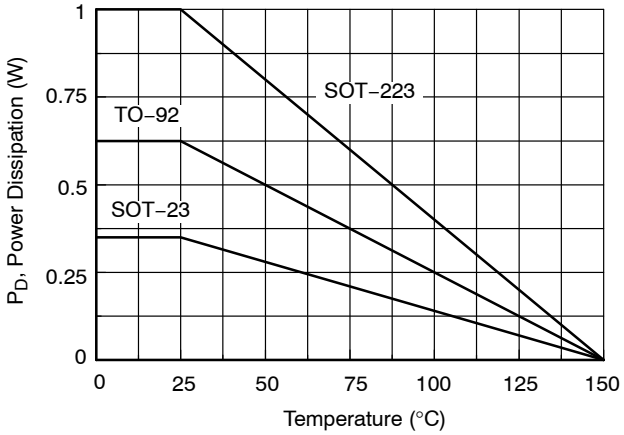

Figure 9. Maximum Safe Operating Area

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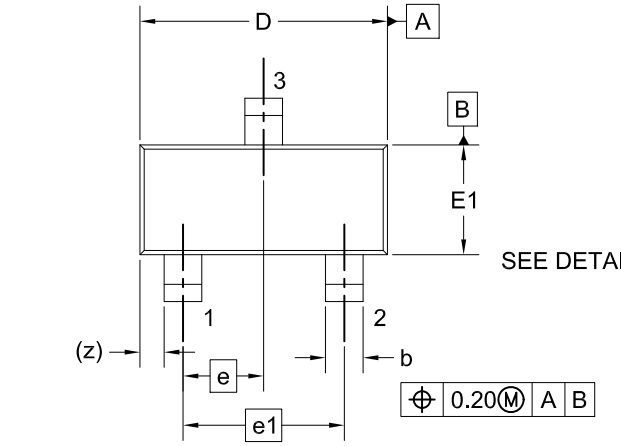
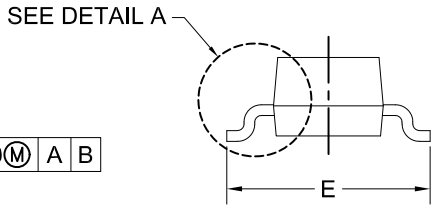
ISSUE A

DATE 01 SEP 2021

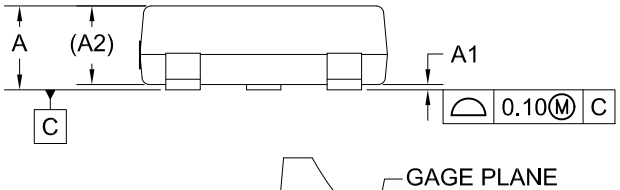


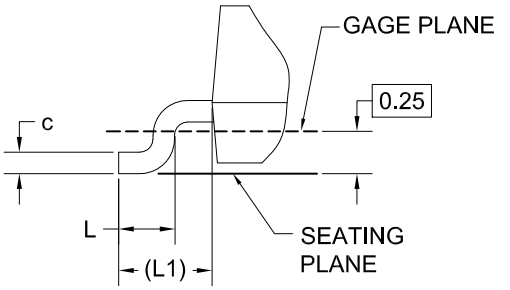


NOTES: UNLESS OTHERWISE SPECIFIED

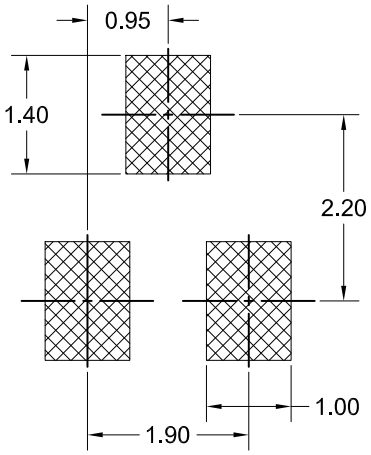
A) REFERENCE JEDEC REGISTRATION TO-236, VARIATION AB, ISSUE H.
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS ARE INCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.
D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M - 2009.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	---	---	1.20
A1	0.00	0.05	0.10
A2	0.93 REF		
b	0.37	0.44	0.60
c	0.08	0.15	0.23
D	2.72	2.92	3.12
E	2.10	2.40	2.70
E1	1.15	1.30	1.50
e	0.95 BSC		
e1	1.90 BSC		
L	0.20	---	---
L1	0.55 REF		
z	0.29 REF		





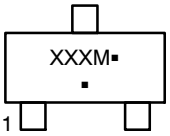
DETAIL A
SCALE: 2X



LAND PATTERN
RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC
MARKING DIAGRAM*



XXX = Specific Device Code
M = Date Code
▪ = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “▪”, may or may not be present. Some products may not follow the Generic Marking.

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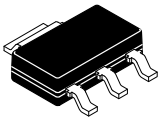
CASE 318H
ISSUE B

DATE 13 MAY 2020



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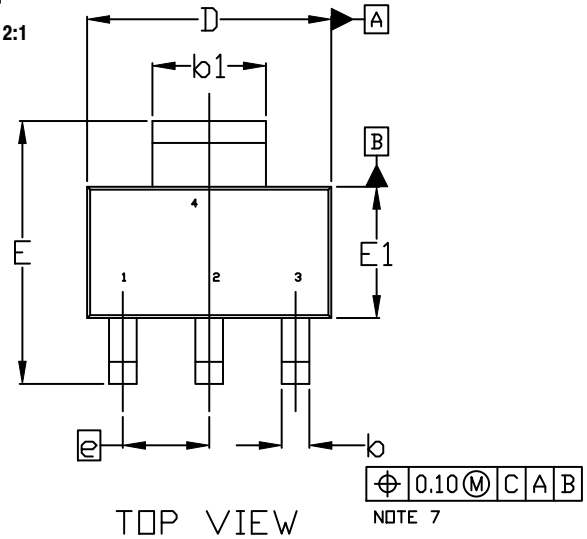
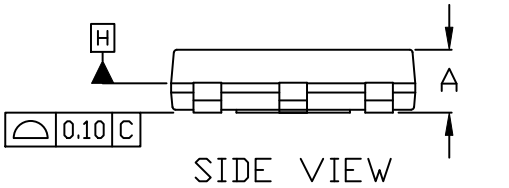
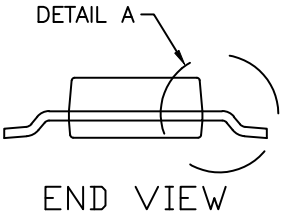
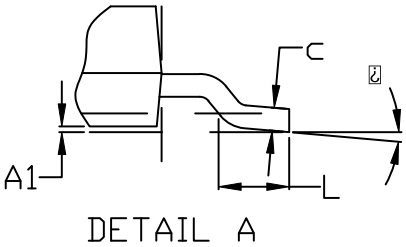


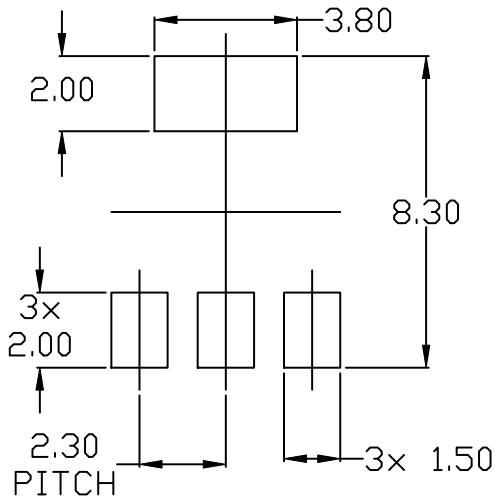






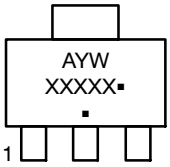
NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS D & E1 ARE DETERMINED AT DATUM H. DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. SHALL NOT EXCEED 0.23mm PER SIDE.
4. LEAD DIMENSIONS b AND b1 DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION IS 0.08mm PER SIDE.
5. DATUMS A AND B ARE DETERMINED AT DATUM H.
6. A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
7. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS b AND b1.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	---	---	1.80
A1	0.02	0.06	0.11
b	0.60	0.74	0.88
b1	2.90	3.00	3.10
c	0.24	---	0.35
D	6.30	6.50	6.70
E	6.70	7.00	7.30
E1	3.30	3.50	3.70
e	2.30 BSC		
L	0.25	---	---
θ	0°	---	10°



RECOMMENDED MOUNTING FOOTPRINT

GENERIC MARKING DIAGRAM*



A	= Assembly Location
Y	= Year
W	= Work Week
XXXXX	= Specific Device Code
▪	= Pb−Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

* For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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